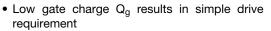


## N-Channel 500V (D-S)Power MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	500				
$R_{DS(on)}(\Omega)$	V <sub>GS</sub> = 10 V	1.1			
Q <sub>g</sub> max. (nC)	49				
Q <sub>gs</sub> (nC)	13				
Q <sub>gd</sub> (nC)	20				
Configuration	Single				

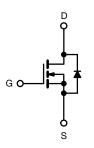
#### **FEATURES**





- Improved gate, avalanche and dynamic dV/dt ruggedness
- Fully characterized capacitance and avalanche voltage and current





N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T <sub>C</sub> = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V <sub>DS</sub>	500		
Gate-Source Voltage			$V_{GS}$	±20	V	
Continuous Drain Current	V <sub>GS</sub> at 10 V	$T_C = 25 ^{\circ}C$ $T_C = 100 ^{\circ}C$	,	8.0		
		T <sub>C</sub> = 100 °C	I <sub>D</sub>	5.8	Α	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	37		
Linear Derating Factor				1.3	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	290	mJ	
Repetitive Avalanche Current a			I <sub>AR</sub>	9.2	А	
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	17	mJ	
Maximum Power Dissipation $T_C = 25 ^{\circ}C$			$P_{D}$	170	W	
Peak Diode Recovery dV/dt c			dV/dt	5.0	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C	
Soldering Recommendations (Peak temperature) d	for	10 s		300		
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque				1.1	N · m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Starting T<sub>J</sub> = 25 °C, L = 6.8 mH, R<sub>g</sub> = 25  $\Omega$ , I<sub>AS</sub> = 9.2 A (see fig. 12). c. I<sub>SD</sub>  $\leq$  9.2 A, dI/dt  $\leq$  50 A/µs, V<sub>DD</sub>  $\leq$  V<sub>DS</sub>, T<sub>J</sub>  $\leq$  150 °C.
- d. 1.6 mm from case.



THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	62			
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.50	-	°C/W		
Maximum Junction-to-Case (Drain)	$R_{thJC}$	-	0.75			

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static		•					•
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		500	-		V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referen	Reference to 25 °C, I <sub>D</sub> = 1 mA		660	-	mV/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub>	= V <sub>GS</sub> , I <sub>D</sub> = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>		V <sub>GS</sub> = ± 20V		-	± 100	nA
Zero Gate Voltage Drain Current	lpaa		$= 500 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$	-	-	25	μА
Zero date voltage Brain ourrent	I <sub>DSS</sub>	$V_{DS} = 400^{\circ}$	V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	250	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	$V_{GS} = 10 \text{ V}$	I <sub>D</sub> = 5.5 A <sup>b</sup>	-	1.10	-	Ω
Forward Transconductance	9 <sub>fs</sub>	$V_{DS}$	$= 50 \text{ V}, I_D = 5.5 \text{ A}$	5.5	-	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>		$V_{GS} = 0 V$ ,	-	1400	-	
Output Capacitance	C <sub>oss</sub>		$V_{DS} = 25 V$ ,	-	180	-	
Reverse Transfer Capacitance	$C_{rss}$	f = 1	f = 1.0 MHz, see fig. 5		7.1	-	pF
Output Capacitance	C <sub>oss</sub>		V <sub>DS</sub> = 1.0 V, f = 1.0 MHz	-	1957	-	- μ <sub>Γ</sub>
		$V_{GS} = 0 V$	V <sub>DS</sub> = 400 V, f = 1.0 MHz	-	49	-	
Effective Output Capacitance	C <sub>oss</sub> eff.		V <sub>DS</sub> = 0 V to 400 V	-	96	-	
Total Gate Charge	$Q_g$			-	-	49	nC
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V	$I_D = 8.0 \text{ A}, V_{DS} = 400 \text{ V}$ see fig. 6 and 13 b	=	-	13	
Gate-Drain Charge	Q <sub>gd</sub>		see lig. 6 and 15	-	-	20	
Turn-On Delay Time	t <sub>d(on)</sub>			-	13	-	
Rise Time	t <sub>r</sub>	V <sub>DD</sub> = 300 V, I <sub>D</sub> = 8.0 A		-	25	-	1
Turn-Off Delay Time	t <sub>d(off)</sub>	$R_{q}$ = 9.1 Ω, $R_{D}$ = 35.5 Ω, see fig. 10 b		-	30	-	ns
Fall Time	t <sub>f</sub>	- 11g - 3.1 sz, np = 33.3 sz, see lig. 10 -		-	22	-	
Gate Input Resistance	R <sub>g</sub>	f = 1 MHz, open drain		0.5	-	3.2	Ω
<b>Drain-Source Body Diode Characteristic</b>	s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	9.2	^
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			=	-	37	A
Body Diode Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 9.2 A, V <sub>GS</sub> = 0 V <sup>b</sup>		-	-	1.5	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = 9.2 A, dl/dt = 100 A/μs b		-	530	800	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	3.0	4.4	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> and L <sub>D</sub> )					L <sub>D</sub> )

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width  $\leq 300~\mu s$ ; duty cycle  $\leq 2~\%$ . c.  $C_{oss}$  effective is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DS}$ .



#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

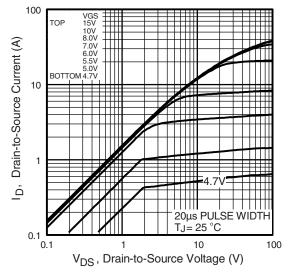


Fig. 1 - Typical Output Characteristics

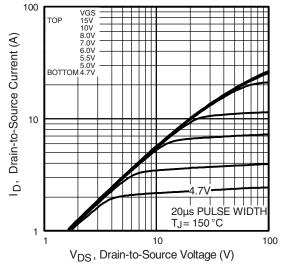


Fig. 2 - Typical Output Characteristics

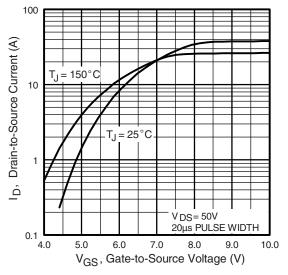


Fig. 3 - Typical Transfer Characteristics

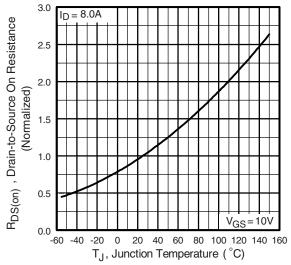


Fig. 4 - Normalized On-Resistance vs. Temperature



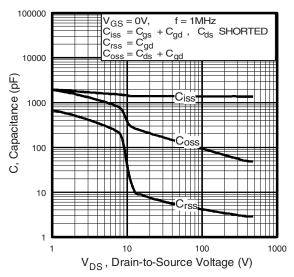


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

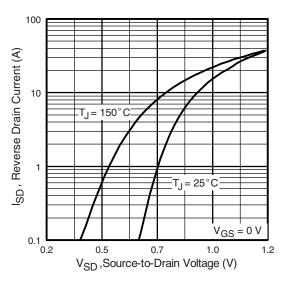


Fig. 7 - Typical Source-Drain Diode Forward Voltage

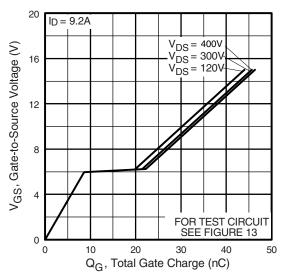


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

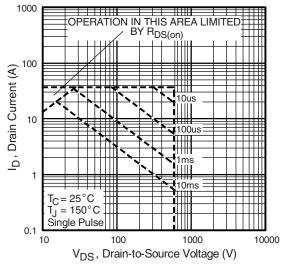


Fig. 8 - Maximum Safe Operating Area



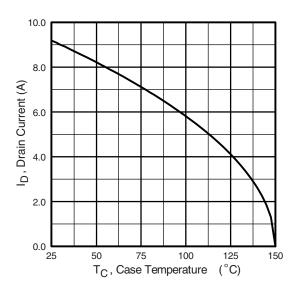


Fig. 9 - Maximum Drain Current vs. Case Temperature

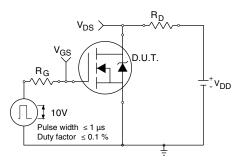


Fig. 10a - Switching Time Test Circuit

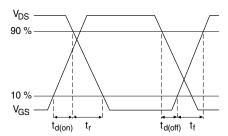


Fig. 10b - Switching Time Waveforms

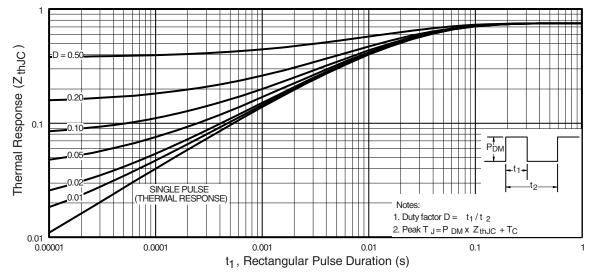


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



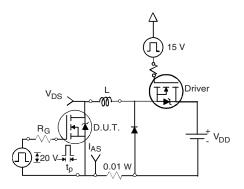


Fig. 12a - Unclamped Inductive Test Circuit

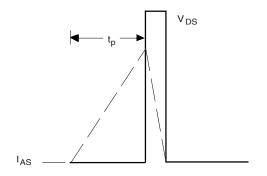


Fig. 12b - Unclamped Inductive Waveforms

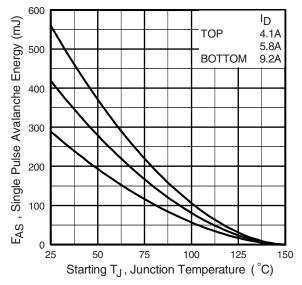


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

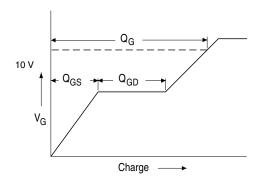


Fig. 13a - Basic Gate Charge Waveform

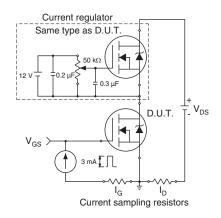
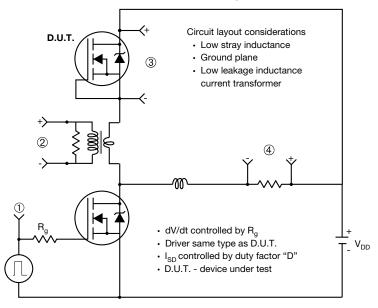


Fig. 13b - Gate Charge Test Circuit



#### Peak Diode Recovery dV/dt Test Circuit



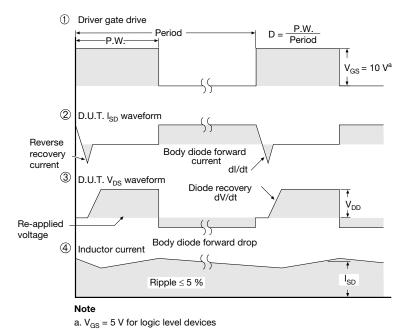
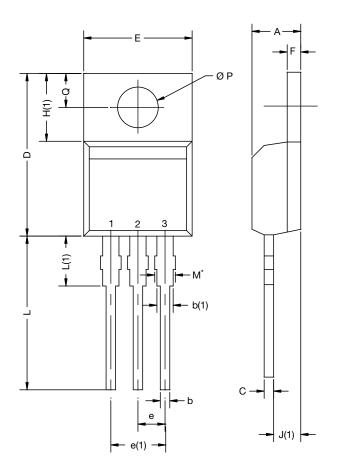


Fig. 14 - For N-Channel



## TO-220-1



DIM	MILLIM	IETERS	INCHES			
DIM.	MIN.	MAX.	MIN.	MAX.		
Α	4.24	4.65	0.167	0.183		
b	0.69	1.02	0.027	0.040		
b(1)	1.14	1.78	0.045	0.070		
С	0.36	0.61	0.014	0.024		
D	14.33	15.85	0.564	0.624		
Е	9.96	10.52	0.392	0.414		
е	2.41	2.67	0.095	0.105		
e(1)	4.88	5.28	0.192	0.208		
F	1.14	1.40	0.045	0.055		
H(1)	6.10	6.71	0.240	0.264		
J(1)	2.41	2.92	0.095	0.115		
L	13.36	14.40	0.526	0.567		
L(1)	3.33	4.04	0.131	0.159		
ØР	3.53	3.94	0.139	0.155		
Q	2.54	3.00	0.100	0.118		
ECN: X15-0364-Rev. C, 14-Dec-15 DWG: 6031						

### Note

 $\bullet$   $M^{\star}=0.052$  inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM



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